NSD7312

Brushed DC Motor Driver Single H-Bridge

Datasheet (EN) 1.5

Product Overview

The device NSD7312 is a brushed-DC motor H-bridge driver for Automotive VCU/OBC charger inlet locking, and industrial market including printer, appliance, robotics or other small machines application. Two logic inputs control the H-bridge driver consisted of four N-channel MOSFETs. The device can control motors bidirectionally with up to 3.6A peak current. The input can be PWM modulated to control motor speed using current chopping method. The device enters sleep mode with low quiescent with both inputs IN1, IN2 low.

The device is integrated with current chopping regulation, based on internal reference and the voltage on the ISEN pin, which is proportional to current flowing through motor through an external sense resistor. The current chopping function limit the peak current to a known level can reduce the system power requirements and bulk capacitance required to maintain stable output voltage especially for motor startup and stall condition.

The device is also fully protected from faults and short circuits, including undervoltage, overcurrent and overtemperature. Also, it provides dedicated nFAULT pin to indicate fault status and alert to microcontroller. When fault condition is removed, the device automatically resumes normal operation.

Applications

- Printers
- Appliances
- Industrial Equipment
- Electrical Lock
- VCU/OBC charger inlet locking

Device Information

Part Number	*Package*	*Body Size*
NSD7312-DHSPR	HSOP8	4.90mm × 3.90mm
NSD7312-Q1HSPR	HSOP8	4.90mm × 3.90mm

Key Features

- Single H-Bridge Motor Driver
- Wide 5-V to 36-V Operating Voltage
- 520mΩ Typical $R_{DS(ON)}$ (HS + LS)
- 3.6-A Peak / 1.5-A continuous Current Drive
- PWM Control Interface
- Integrated Current Regulation
- Low-Power Sleep Mode
- Small Package and Footprint
- 8-Pin HSOP 4.9mm X 3.9mm with exposed PAD
- Integrated Protection Features
  - VM Undervoltage Lockout (UVLO)
  - Overcurrent Protection (OCP)
  - Thermal Shutdown (TSD)
  - Fault indicating (nFAULT) and Automatic Fault Recovery
- Industrial temperature grade (NSD7312)
- AEC-Q100 Grade 1 Qualified

  Automotive temperature grade (NSD7312-Q1)

Functional Block Diagrams

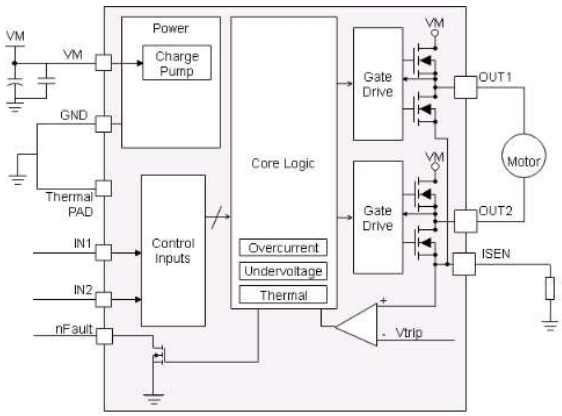


Figure 1. NSD7312 Block Diagram

1. Pin Configuration and Functions

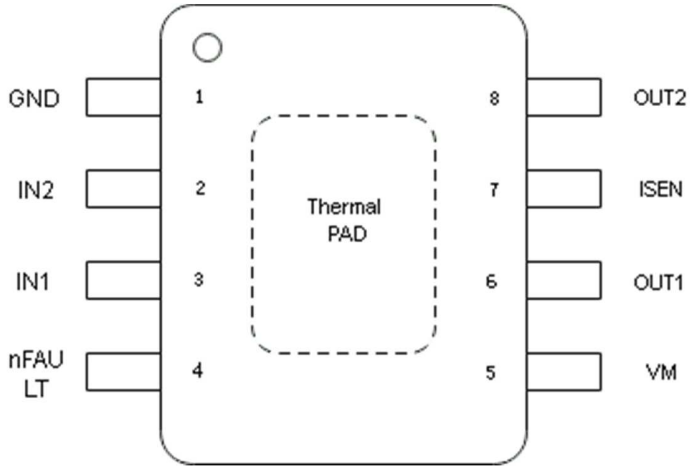


Figure 2. NSD7312 Pinout (top view)

Table 1. NSD7312 Pin Configuration and Description

SYMBOL	No	TYPE	DESCRIPTION
GND	1	PWR	Logic ground. Connect to board ground
IN1	3	I	Logic inputs 1. Controls the H-bridge output. Has internal pull downs.
IN2	2	I	Logic inputs 2. Controls the H-bridge output. Has internal pull downs.
ISEN	7	PWR	High-current ground path. If using current regulation, connect ISEN to a resistor (low-value, high-power-rating) to ground. If not using current regulation, connect ISEN directly to ground.
OUT1	6	O	H-bridge output1 pin. Connect directly to the motor or other inductive load.
OUT2	8	O	H-bridge output2 pin. Connect directly to the motor or other inductive load.
VM	5	PWR	5V to 36V power supply. Connect a 0.1-μF bypass capacitor to ground, as well as sufficient bulk capacitor needs to guarantee VM pin voltage in maximum range.
nFAULT	4	O	Open-drain output for fault indication. Pull low when fault (OCP, OT, VUVLO) happens. Connect external pull up resistor, typ. 4.7k/10k
Thermal PAD	—		Thermal pad. Connect to board ground. For good thermal dissipation, use large ground planes on multiple layers, and multiple nearby vias connecting those planes.

2. Absolute Maximum Rating

ITEMS	MIN	MAX	UNIT
Power supply voltage (VM)	–0.3	40	V
Logic input voltage (IN1, IN2)	–0.3	6	V
Fault output pin (nFAULT)	–0.3	6	V
Continuous phase node pin voltage (OUT1, OUT2)	–0.7	VM + 0.7	V
Current sense input pin voltage (ISEN)	–0.5	0.5	V

3. ESD Ratings

SYMBOL	DESCRIPTION	VALUE	UNIT
VESD	Human Body Model (HBM) (1), per AEC-Q100-002	±2000	V
	Charged device model (CDM) (1), per AEC-Q100-011, all pins	±500	V
	Charged device model (CDM) (1), per AEC-Q100-011, corner pins (1,4,5,8)	±750	V

(1) ± 2000v HBM and ± 500v CDM allows safe manufacturing with a standard ESD control process. Pins listed as ± 2000 V HBM & ± 500v CDM may actually have higher performance.

4. Recommended Operating Conditions

SYMBOL	DESCRIPTION	MIN	TYP	MAX	UNIT
VM	VM Power supply voltage	5		36	V
V_{OD}	nFAULT output voltage range	0		5	V
I_{OD}	nFAULT open drain load current	0		5	mA
VIN1, VIN2	Logic input voltage (IN1, IN2)	0		5.5	V
fpwm	Logic input PWM frequency (IN1, IN2)	0		200	kHz
Imax	Max output current (2)	0		3.6	A

(2) When the maximum allowable output load current is considered during application scenario, both power dissipation and thermal condition, including ambient temperature, application board thermal condition etc., shall also be evaluated.

5. Thermal Information

SYMBOL	DESCRIPTION	MIN	TYP	MAX	UNIT
Ta	Ambient operating ambient temperature	-40		125	°C
Tj	Junction temperature	-40		150	°C
Tstg	Storage temperature	-65		150	°C

Rthjc	Thermal resistance, junction to case		2.7		°C/W
Rthja	Thermal resistance, junction to ambient, on 2-layer PCB		62		°C/W
	Thermal resistance, junction to ambient, on 4-layer PCB based on JEDEC standard		35		°C/W

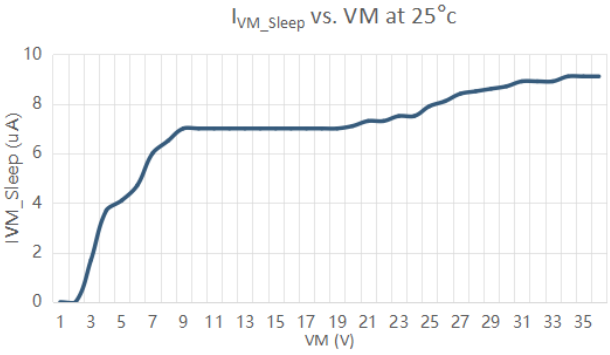
6. Electrical characteristics

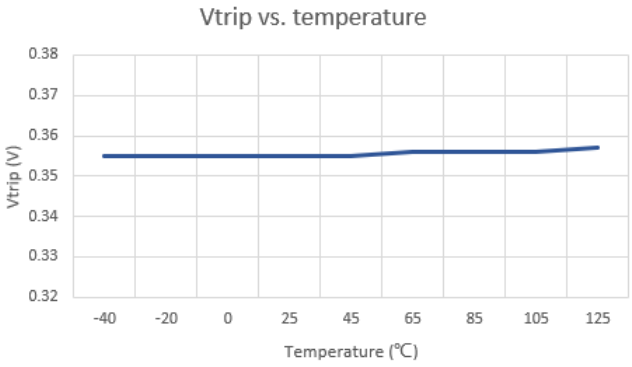
Valid for industrial version at T_j = 25°C, VM=5 to 36V and for automotive version at T_j = -40 to 150°C, VM=5 to 36V, unless otherwise specified

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
POWER SUPPLY (VM)						
VM	VM operating voltage		5		36	V
I_{VM}	VM operating supply current	VM = 12 V		2	5	mA
$I_{VMSLEEP}$	VM sleep current	VM = 12 V, Ta= 25°c		6	10	μA
t_{ON}	Turn-on time	VM > V_{UVLO} with IN1 or IN2 high		23	50	μs
Logic Control Input (IN1, IN2)						
V_{IL}	Input logic low voltage				0.5	V
V_{IH}	Input logic high voltage		1.8			V
V_{HYS}	Input logic hysteresis			0.5		V
I_{IL}	Input logic low current	VIN = 0 V	-1		1	μA
I_{IH}	Input logic high current	VIN = 3.3 V		33	100	μA
R_{PD}	Pulldown resistance	to GND		100		kΩ
t_{PD}	Propagation delay	INx to OUTx change		0.6	1	μs
t_{sleep}	Time to sleep	Inputs low to sleep		1	1.8	ms
H-BRIDGE OUTPUS (OUT1, OUT2)						
$R_{DS(ON)}$	High-side FET on resistance	VM = 12 V, I = 1 A, Ta= 25°c		285		mΩ
		VM = 12 V, I = 1 A, Ta= 125°c			580	mΩ
$R_{DS(ON)}$	Low-side FET on resistance	VM = 12 V, I = 1 A, Ta= 25°c		235		mΩ
		VM = 12 V, I = 1 A, Ta= 125°c			490	mΩ
t_{DEAD}	Output dead time			200		ns
V_d	Body diode forward voltage	IOUT = 1 A		0.8	1.2	V
CURRENT REGULATION						
t_{OFF}	PWM off-time			25		μs

t_{BLANK}	PWM blanking time			2		µs
$t_{deglitch}$	Current regulation deglitch timing			0.6		µs
V_{TRIP}	ISEN chopping voltage		0.32	0.35	0.38	V
PROTECTION						
V_{UV}	VM undervoltage protection	VM falls until UV triggers	4.2	4.6		V
		VM rises until operation recovers		4.75	5.1	V
V_{UV_HYS}	VM undervoltage hysteresis			150		mV
t_{UV}	VM undervoltage deglitch time			10		µs
I_{OCP}	Overcurrent protection threshold		3.7	4.5	6.4	A
t_{OCP}	Overcurrent deglitch time			1.5		µs
t_{RETRY}	Overcurrent retry time			3		ms
T_{SD}	Thermal shutdown temperature		150	165	180	°C
T_{HYS}	Thermal shutdown hysteresis			20		°C
nFAULT OPEN DRAIN OUTPUT						
I_{OH}	Output high leakage current	V_{OD} = 5V			1	µA
V_{OL}	Output low voltage	Input current 5mA			0.5	V

7. Typical Characteristics





8. Functional description

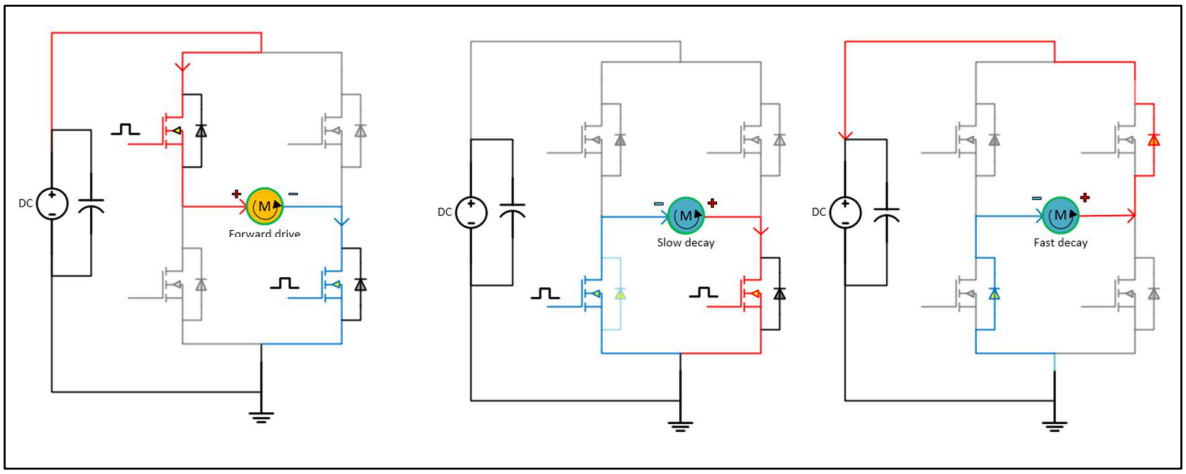
8.1. H-bridge operation

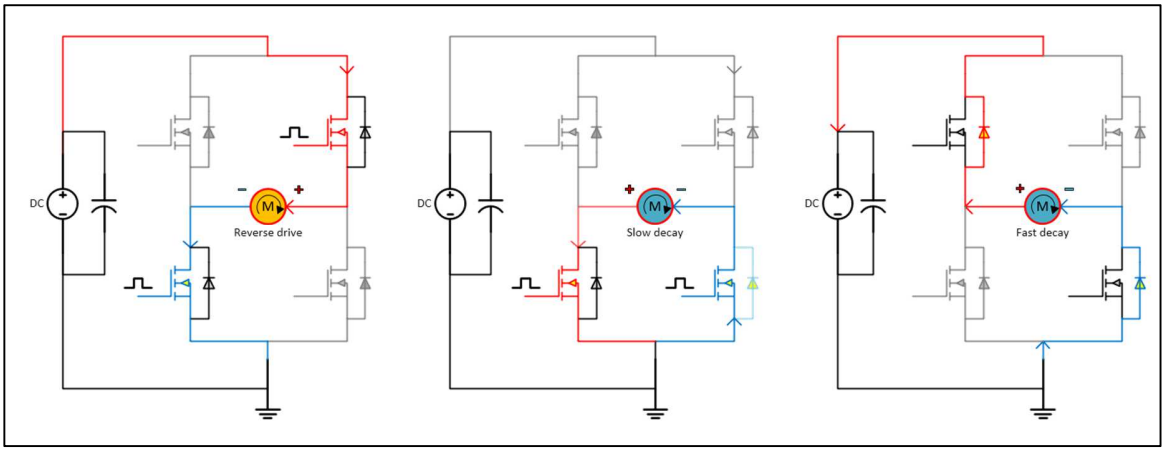
The NSD7312 contains two logic input pins IN1 and IN2, the two pins are internally pulled down and able to receive up to max 200kHz PWM signal, for controlling the internal integrated output stage to support motor operation in different states as below table 2.

Table 2. NSD7312 operation state description

IN1	IN2	$V_{ISEN} > V_{TRIP}$	OUT1	OUT2	Description
1	0	False	HIGH	LOW	Normal driving, forward mode
0	1	False	LOW	HIGH	Normal driving, reverse mode
1	0	True	HIGH/LOW	LOW	Current regulation, forward
0	1	True	LOW	HIGH/LOW	Current regulation, reverse
1	1	x	LOW	LOW	Slow decay
0	0	x	HIZ	HIZ	Fast decay mode. Device move from fast decay to low power sleep mode after both IN1 and IN2 move to 0 for 1ms typ (t_{sleep})

Figure 3. High side/low side activation in forward/reverse/slow decay/fast decay





An internal dead-time t_{DEAD} is implemented between internal high side and low side switching to avoid cross conduction.

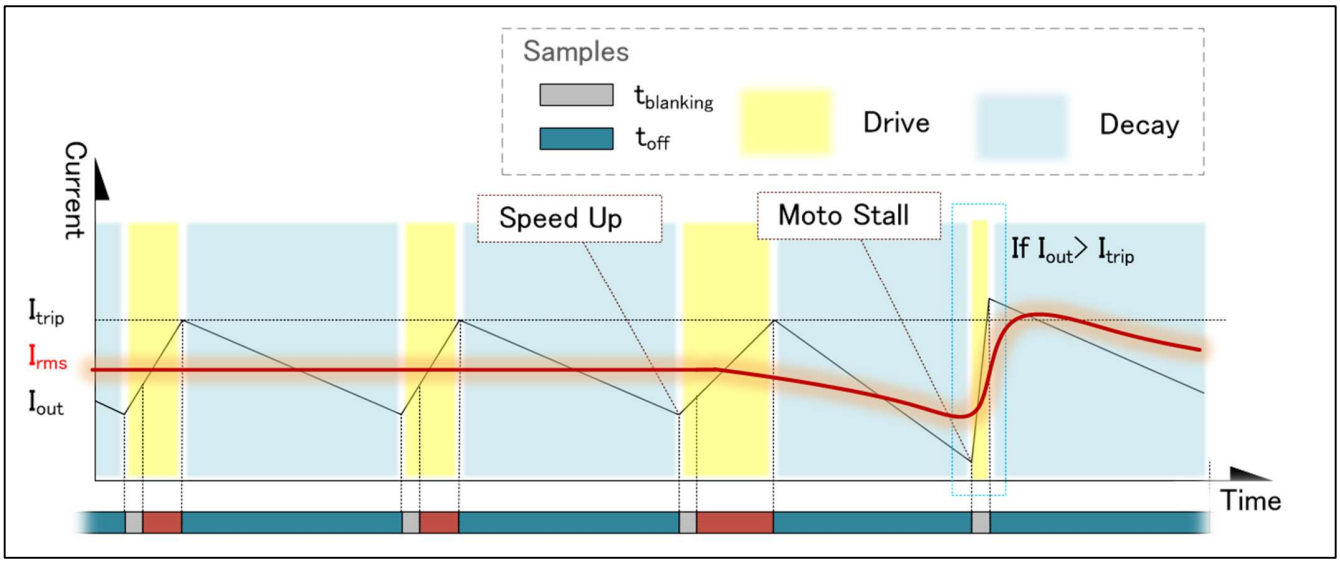
8.2. ISEN pin and current regulation

A low value, enough power rating resistor must be placed between ISEN pin and power ground. Together with the internal Voltage reference V_{TRIP}, the current regulation level I_{TRIP} is set according to the external shunt resistant from ISEN pin to GND, calculation formula as:

$$I_{trip} = \frac{V_{TRIP}}{R_{ISEN}} = \frac{0.35}{R_{ISEN}}$$

The NSD7312 use fixed off-time current regulation. When the load current reaches the setting I_{TRIP} after the blanking time, the internal controller automatically moves the H-Bridge output to slow decay state by two internal low side MOSFET in ON state, until t_{OFF} elapses, the H-bridge returns to driving state according to IN1/IN2 pin status starting with blanking time t_{BLANK} which mask the voltage and current transient during the output switching.

Figure 4. Current chopping regulation schemes



8.3. Low power sleep mode

Low power sleep mode in NSD7312 is active when both IN1 and IN2 keeps for low after 1ms (typ.) t_{sleep}. It disables most internal circuits, including charge pump and control logic blocks etc., and reduces device current consumption.

When one of IN1 or IN2 pins state moves to high and remains at least 5us, the device exits from low power sleep mode. After 23us (typ.) t_{ON} delay timing, OUT1 and OUT2 can be active in normal driving reverse / forward according to IN1 and IN2 inputs.

8.4. Protection function

8.4.1. VM undervoltage protection

When VM power supply pin voltage falls below the undervoltage low threshold (V_{UV}) over 10us typ. undervoltage deglitch time, OUT1 and OUT2 becomes HIZ and internal power stage Mosfets are disabled. When VM rise above the $V_{UV(HIGH)}$, the device automatically resumes normal operation according to IN1/IN2 pin status.

8.4.2. Overcurrent protection

The device integrates internal current monitor to against output load short, OUT1 / OUT2 pin short to battery or GND. If one of these faults happens and internal sensed current > OCP threshold I_{OCP} for longer than t_{OCP}, all H-bridge output MOSFET are disabled.

In the meantime, device provides overcurrent protection recovery function by auto-retry mechanism. After H-bridge output MOSFET disabled for the duration t_{RETRY}, it automatically re-enables and works according to the state of IN1/IN2 pins. While OCP fault is still present, the protection and auto retry repeats; otherwise, the device moves to normal operation state.

8.4.3. Overtemperature

If the device internal junction temperature over T_{SD} threshold, the internal MOSFET also automatically disabled. Normal operation will be resumed when internal junction temperature drops below T_{SD}-T_{HYS}

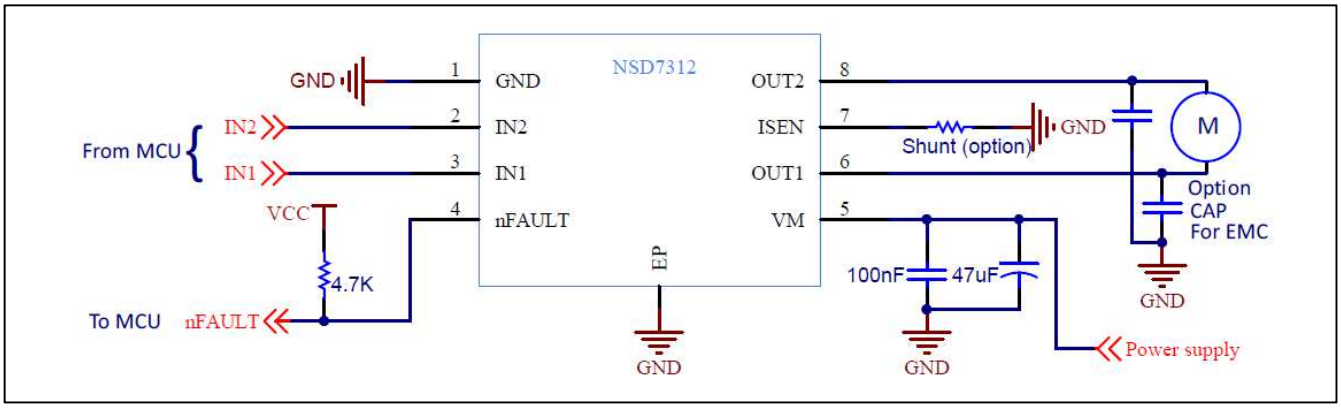
8.4.4. Fault Protection Summary

Fault	Condition	H-Bridge	nFAULT	Recovery procedure
VM undervoltage	VM < $V_{UV\ (LOW)}$	Disabled, HIZ	LOW	VM > $V_{UV\ (HIGH)}$
OCP	I > I_{OCP}	Disabled, HIZ	LOW	Auto-retry with t_{RETRY} interval
Over temperature	T_J > T_{SD}	Disabled, HIZ	LOW	T_J < T_{SD} - T_{HYS}

9. Application information

9.1. Application diagram

Figure 5. Typical application connection



9.2. ISEN pin and external shunt resistor selection

To limit the load current during motor start-up and stall condition, a low value shunt resistor is usually placed between ISEN pin and GND. The routing trace shall be short and wide to minimize the IR drop and inductance, which avoids the impact on low-value sensing resistor and ISEN pin.

Because resistor is power rated component, the selection of shunt resistor must meet the enough power rating (I^2R) and temperature range requirement, while the proper footprint size of resistor shall also be considered.

For example, I_{TRIP} = 1.5A, R_{ISEN} = 0.35/1.5 = 233mohm & P = I^2R = 0.524W, then R_{ISEN} can be selected using 250mohm shunt with SMT 2512 size rating >1W.

9.3. Device power dissipation and continuous driving current

Total device power dissipation (P_{TOT}) is consisted of three parts: VM supply current and related dissipation (P_{VM}), H-bridge switching loss (P_{SW}) and H-bridge MOSFET ON static power dissipation (P_{ON}).

$$P_{TOT} = P_{VM} + P_{SW} + P_{ON}$$

$$P_{TOT} = VM * I_{VM} + I_{LOAD} * V_M * (t_{rise} + t_{fall}) * f_{PWM} + I_{LOAD}^2 * (R_{DS(ON)_{HS}} + R_{DS(ON)_{LS}})$$

If the input PWM frequency is used below 20kHz, the switching loss P_{SW} is insignificant comparing with P_{ON}, therefore, the power loss of NSD7312 under this condition can be quickly estimated by the formula

$$P_{TOT} \approx I_{RMS}^2 \times (R_{DS(ON)_{HS}} + R_{DS(ON)_{LS}})$$

The device junction temperature calculation is defined as $T_J = T_{amb} + (R_{thja} * P_{TOT})$, for continuous driving, the device internal temperature must be less than Tj max (150°c) for system operating.

9.4. Layout tips

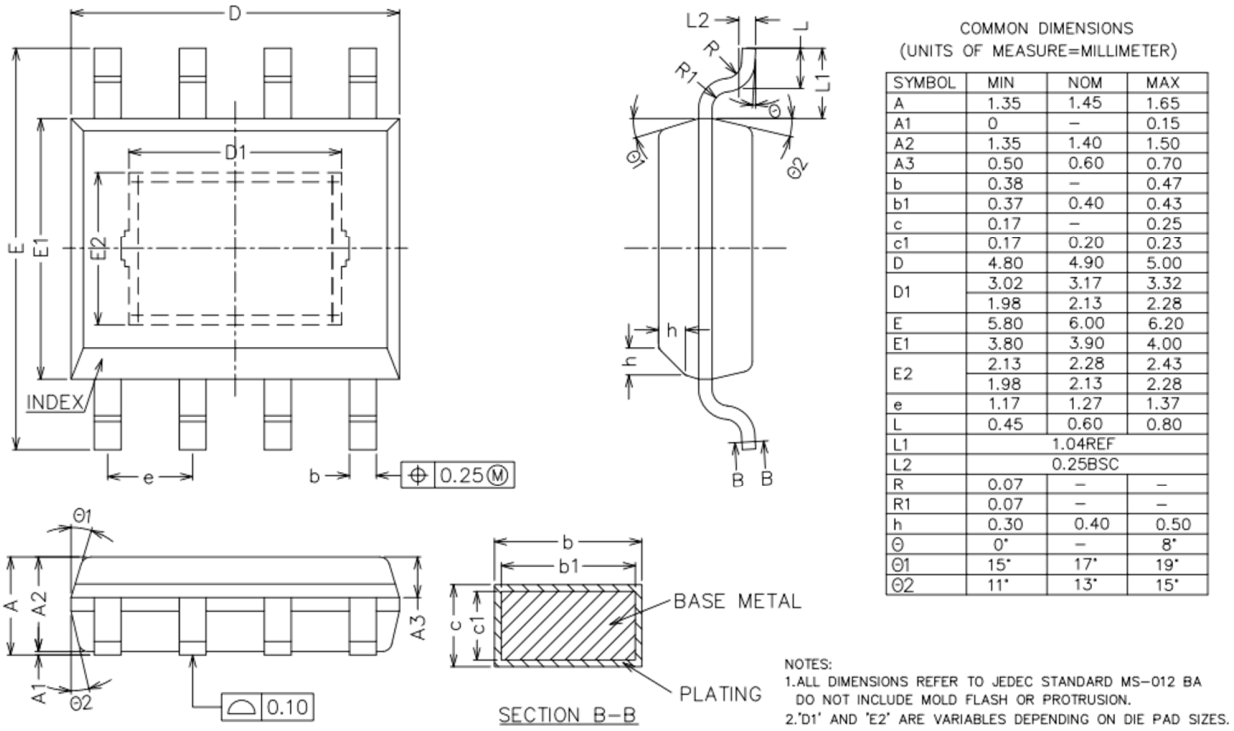
For optimized thermal performance, the NSD7312 exposed pad must be directly soldered to the PCB surface, also multiple vias should be used to transfer the heat to other PCB layers. In the meanwhile, the PCB is recommended to have higher copper coverage and thick ground plane.

For robust and reliable electrical usage, the power supply pin VM should be decoupled with a bulk capacitor (47uF or 100uF) and one low value ceramic capacitor (100nF typical). The placement of two capacitors suggests close to VM pin as much as possible.

The generic option capacitor value on OUT1 & OUT2 for EMC is 10nF. The most appropriated value shall be determined during system-level EMC testing. For layout, put the option EMC capacitor close to output connector is suggested.

10. Package information

10.1. HSOP8 package information



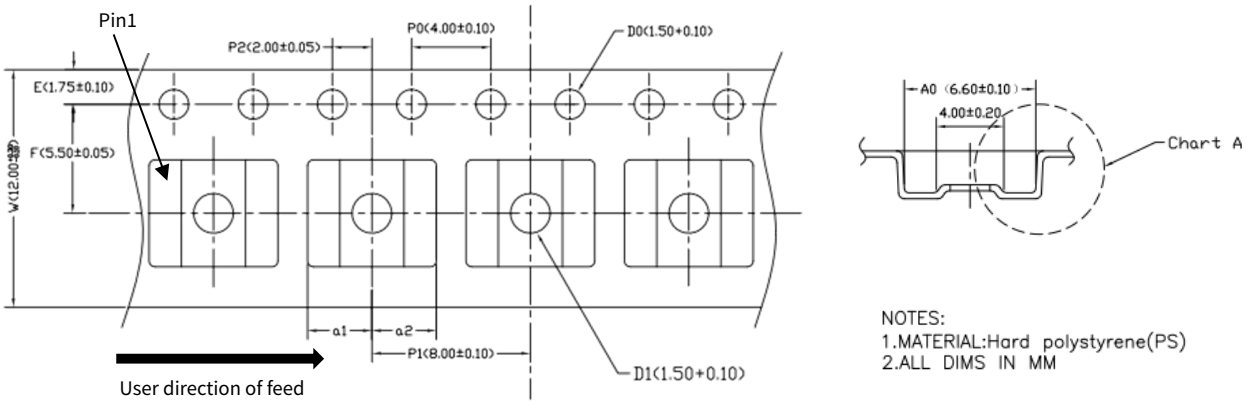
COMMON DIMENSIONS
(UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	NOM	MAX
A	1.35	1.45	1.65
A1	0	–	0.15
A2	1.35	1.40	1.50
A3	0.50	0.60	0.70
b	0.38	–	0.47
b1	0.37	0.40	0.43
c	0.17	–	0.25
c1	0.17	0.20	0.23
D	4.80	4.90	5.00
D1	3.02	3.17	3.32
	1.98	2.13	2.28
E	5.80	6.00	6.20
E1	3.80	3.90	4.00
E2	2.13	2.28	2.43
	1.98	2.13	2.28
e	1.17	1.27	1.37
L	0.45	0.60	0.80
L1		1.04REF	
L2		0.25BSC	
R	0.07	–	–
R1	0.07	–	–
h	0.30	0.40	0.50
θ	0°	–	8°
θ1	15°	17°	19°
θ2	11°	13°	15°

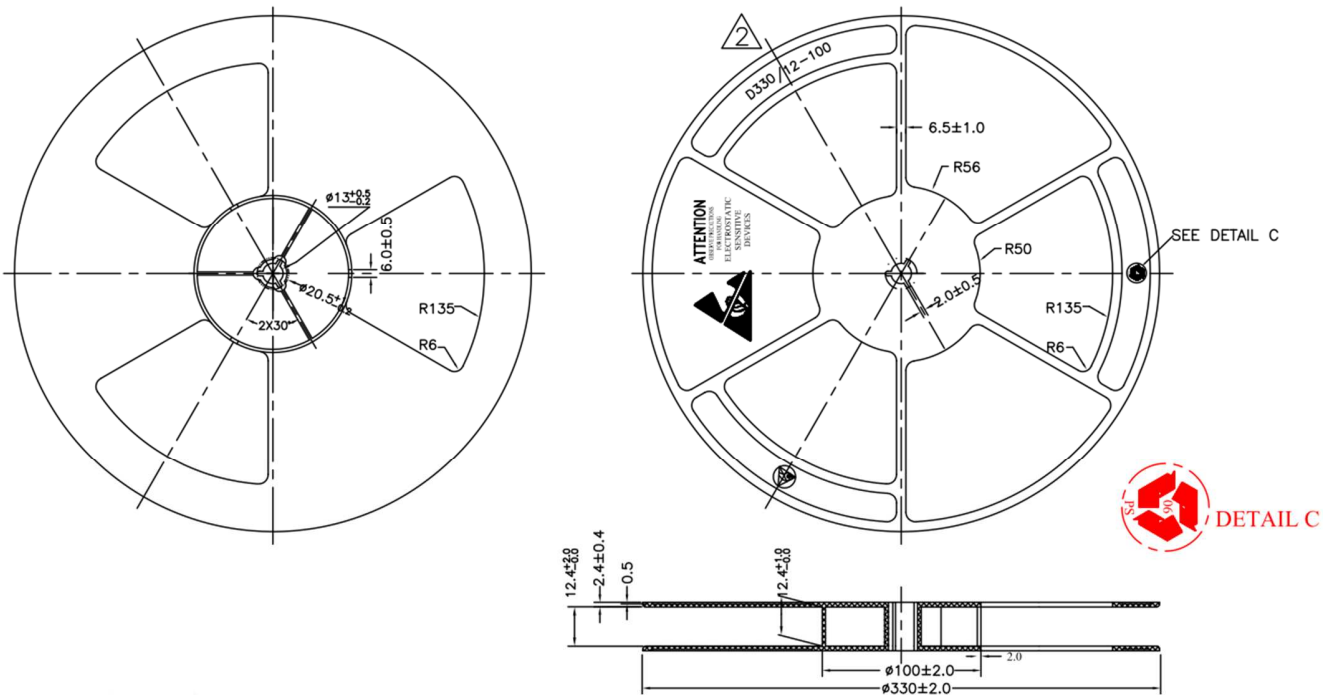
NOTES:
1.ALL DIMENSIONS REFER TO JEDEC STANDARD MS-012 BA
DO NOT INCLUDE MOLD FLASH OR PROTRUSION.
2."D1" AND "E2" ARE VARIABLES DEPENDING ON DIE PAD SIZES.

Note: Variation A, D1 (MIN 3.02, TYP 3.17, MAX 3.32) & E2 (MIN 2.13, TYP 2.28, MAX 2.43), is used.

10.2. HSOP8 packaging information



NOTES:
1.MATERIAL:Hard polystyrene(PS)
2.ALL DIMS IN MM



11. Ordering Information

Part Number	Automotive / Industrial	VREF / VTRIP	NFAULT	IPROBE	Package Type	MSL	SPQ
NSD7312-DHSPR	Industrial	Vtrip 0.35v	YES	NO	HSOP8	MSL3	2500
NSD7312-Q1HSPR	Automotive	Vtrip 0.35v	YES	NO	HSOP8	MSL3	2500
Note: All packages are ROHS compliant with peak reflow temperature of 260°C according to the JEDEC industry standard classifications and peak solder temperature.							

12. Revision History

Revision	Description	Date
1.0	Initial version	2021/11/5
1.1	Correct some typo and add application information about power dissipation	2022/8/28
1.2	Update some datasheet parameters and MSL information	2022/10/14
1.3	Add note for thermal pad size variation and MSL	2022/11/25
1.4	Revise datasheet parameter maximum values and test condition Revise application diagram and add option output EMC capacitor description Revise ordering information table and datasheet format	2023/2/20
1.5	Correct the typo in the unit of VTRIP	2024/5/22

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